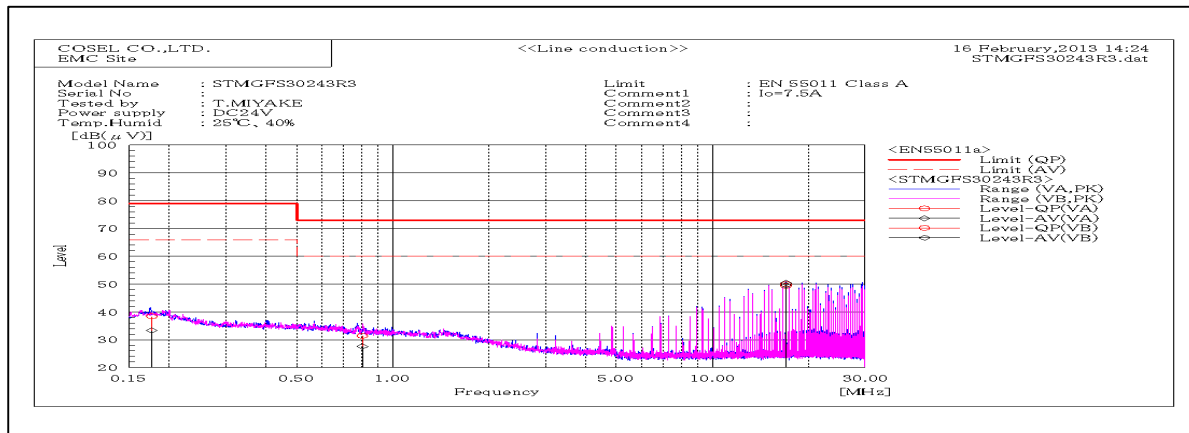
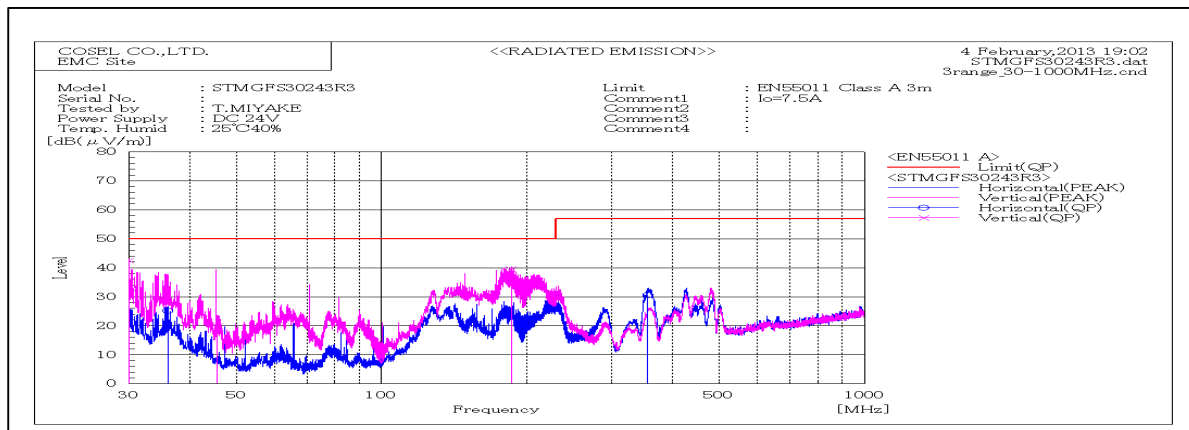


DATA SHEET		Date	18-Feb-13
Model	STMGFS30243R3	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake



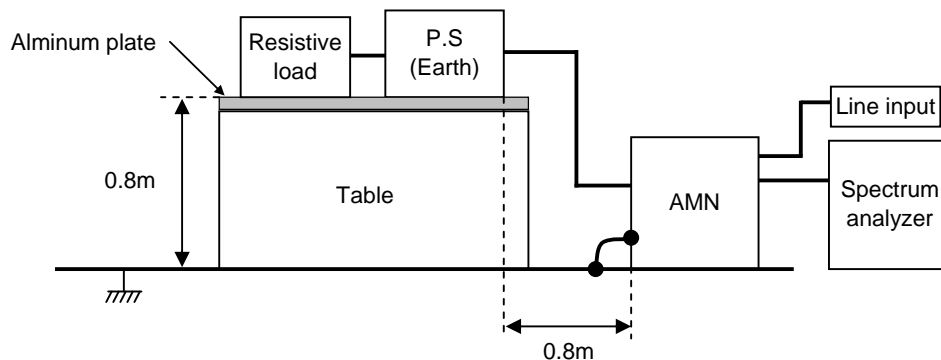
Frequency MHz	Harm	Line Phase	Reading dB(uV)		Factor dB	Level dB(uV)		Limit dB(uV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.17627		VA	18.2	13.1	20.2	38.4	33.3	79	66	40.6	32.7	Pass	
0.80345		VB	11.3	7.5	20.1	31.4	27.6	73	60	41.6	32.4	Pass	
16.97445		VB	28.2	28.5	21.1	49.3	49.6	73	60	23.7	10.4	Pass	
16.9748		VA	28.8	29.1	21.2	50	50.3	73	60	23	9.7	Pass	



Frequency MHz	Polarization	Stability	Reading dB(uV)		Space Loss dB	Level dB(mW)		Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	AV					
30	V	Stable	55.9	-13.4		42.5	50	7.5	Pass	103	86	
36.063	H	Stable	41.5	-16.3		25.2	50	24.8	Pass	157	62	
45.745	V	Stable	40.5	-20.6		19.9	50	30.1	Pass	103	335	
185.519	V	Stable	55.4	-15.9		39.5	50	10.5	Pass	103	287	
356.007	H	Stable	43.7	-13.1		30.6	57	26.4	Pass	102	58	

DATA SHEET		Date	18-Feb-13
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake

1. Line conduction



2. Radiated emission

